

# Benchmarking of GHz resonator techniques for the characterisation of 5G / mmWave materials

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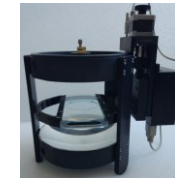
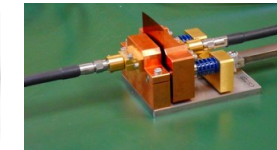
<sup>^</sup>The International Electronics Manufacturing Initiative, US

# Outline

- Motivation & Industry Needs
- Brief Overview of the iNEMI 5G/mmWave Materials Assessment & Characterisation Project



- Why Resonator Techniques & Which Resonators Are Used



- Choice of Benchmarking Material Samples



- Material Measurement Results & Discussion

- Conclusions & Outlook

# Motivation & Industry Needs: Scope

- 5G: Common to only think in terms of 'radio' applications
- '5G' extends beyond wireless applications



Src: Urmi Ray, 5G/High Frequency Materials Characterization Challenges and Opportunities, EMA 2021, S13

- Many forward-looking wired applications need material data spanning DC to 100+GHz
- Dielectric constant measurements are key enablers for many different industries & technologies

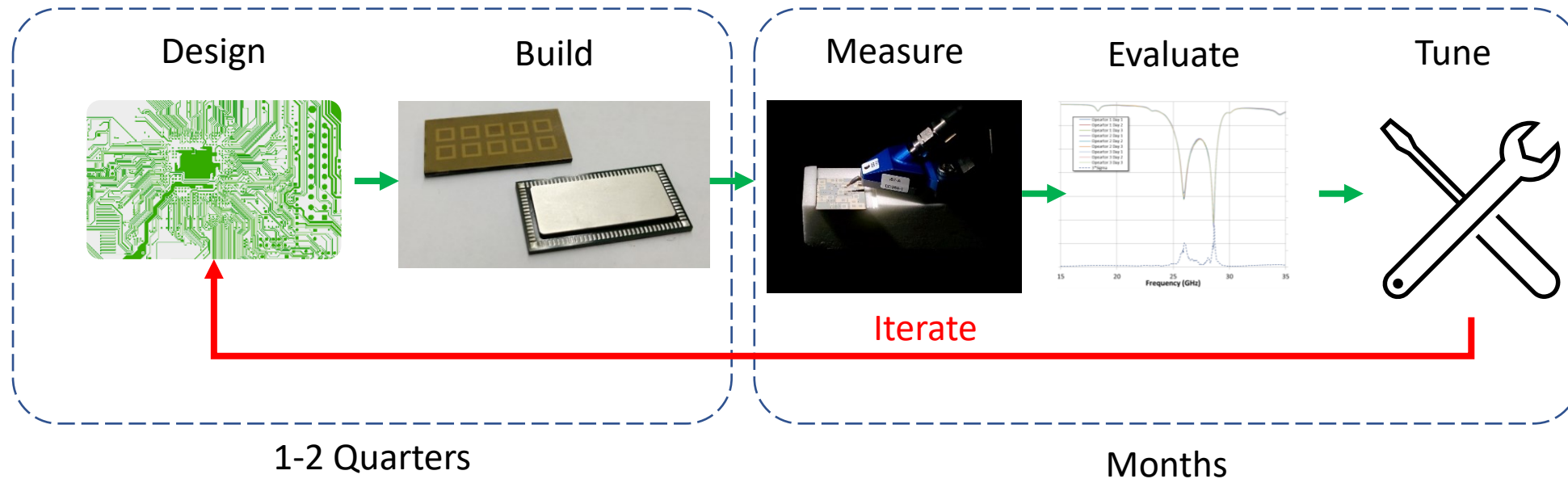
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EuMC27 Measurements for 5G and 6G Systems



# Motivation & Industry Needs: Design

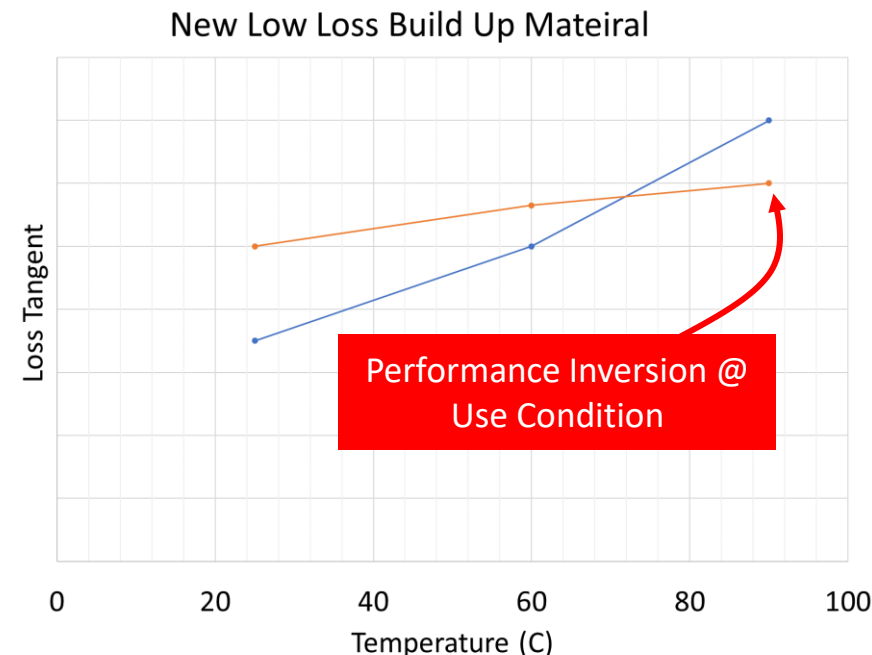
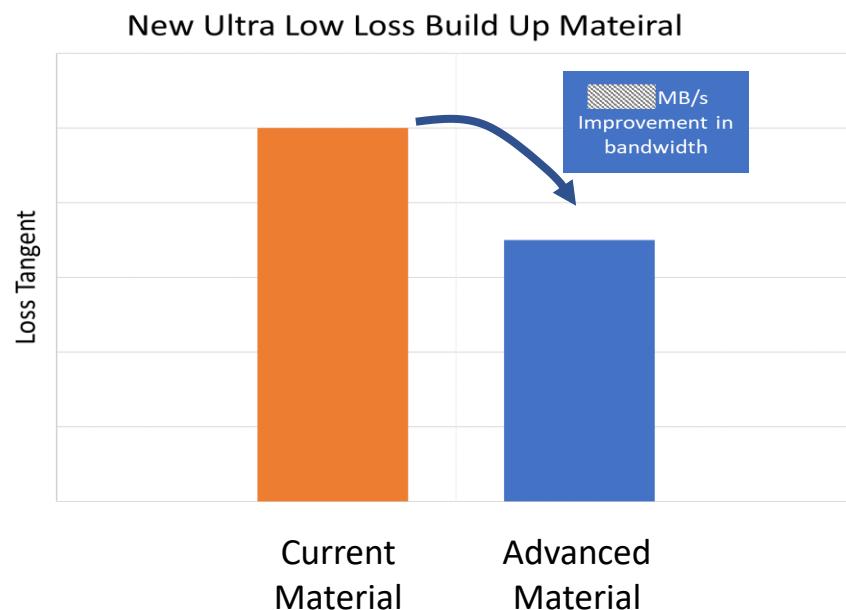
- Traditional methods of microwave design rely on trimming & tuning difficult to tolerate in today's environment...
- Faster & less costly “virtual prototyping” is achieved with today's modelling & simulation tools...
- ...but accurate material data is still required
- ...errors in materials' characterisation limit accuracy of modeling resulting in time consuming iterations





# Motivation & Industry Needs: New Materials

- 5G/mmWave industry is in quest for new ultra-low-loss materials



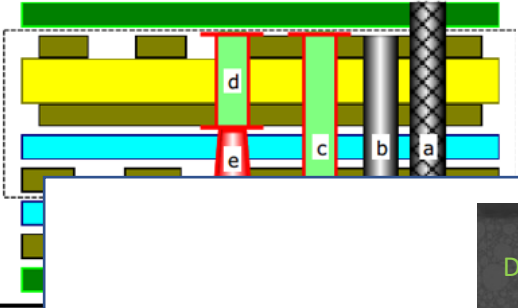
- Developments of new materials require accurate evaluation at use condition

Errors can be very costly, e.g. estimated cost to switch: ~\$2 per CPU substrate → x 20M units = \$40M

**\$10's of millions for a single program, or worse, unexpected product failures**

# Motivation & Industry Needs: On-Site Use

Modern PCBs make use of many different dielectrics



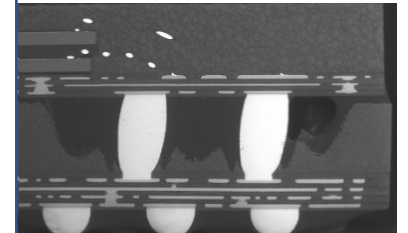
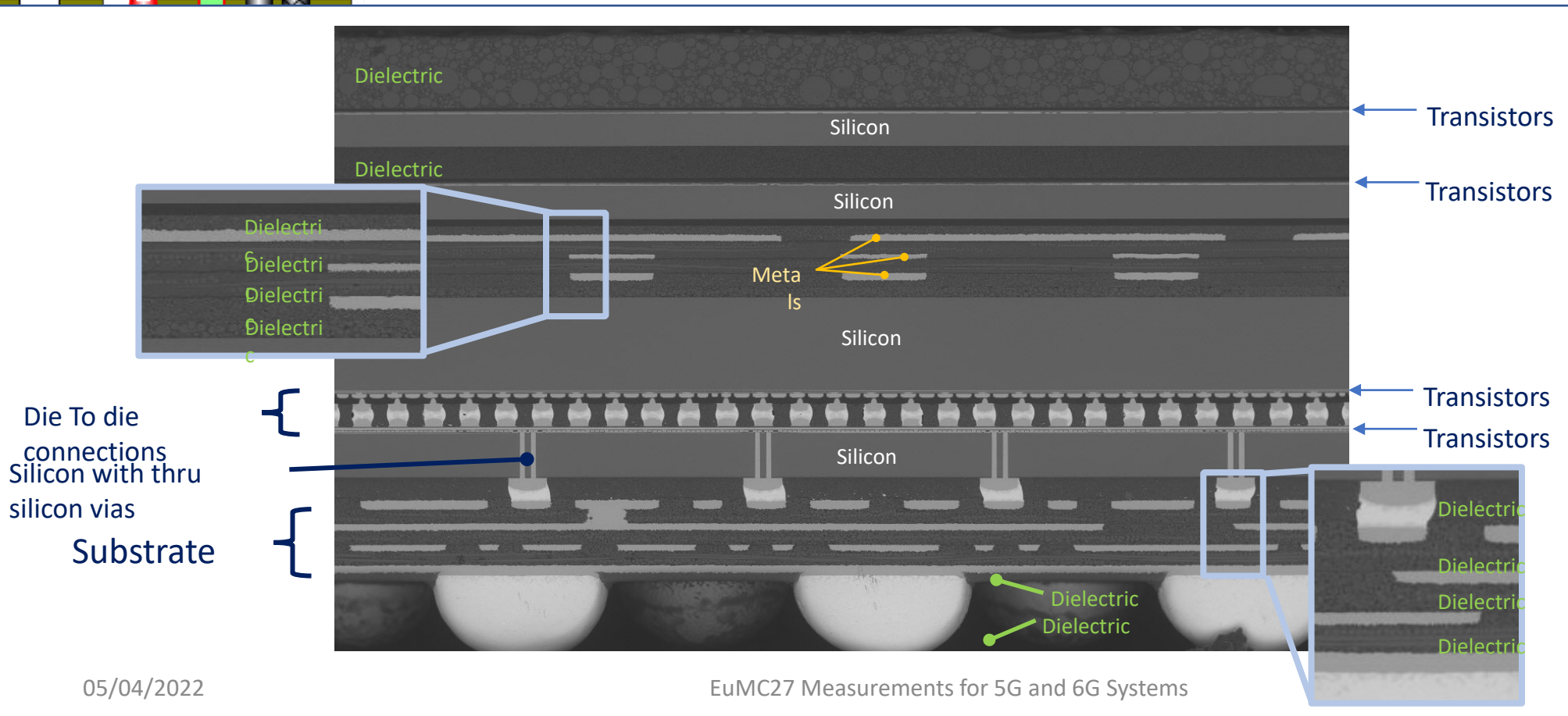
**Need to characterise:**

- many materials
- across many domains of science & engineering

**Desirable techniques:**

- fast & easy-to-use
- robust and reproducible

**Example: Intel measures more than 200 materials per year.**



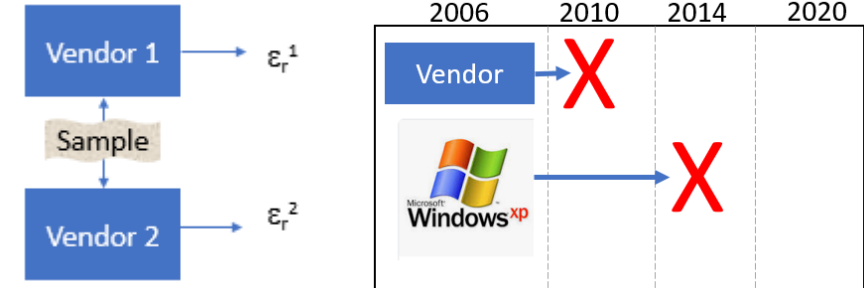
# Gaps & Practical Challenges

**No standards & SRMs** for mmWave Permittivity measurements >20 GHz:

- Challenges for ISO and quality control

**Few vendors** for mmWave Permittivity measurement equipment >10 GHz:

- Explain vendor to vendor differences
- Whom to trust?
- On whom to rely?



Useful 5G materials are typically **very low loss**:

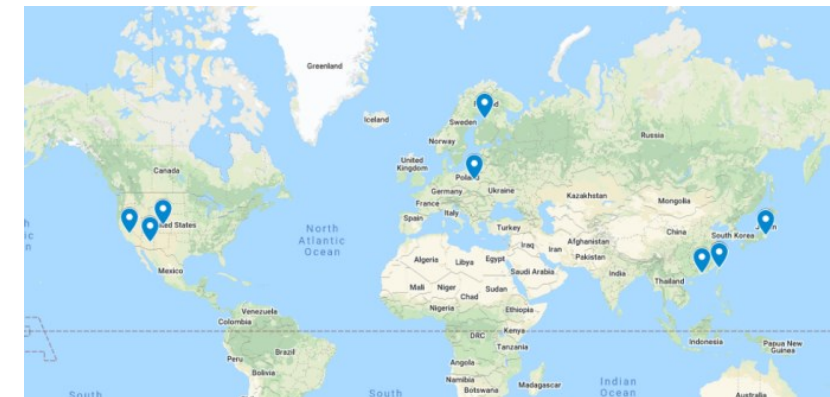
- Eliminates many traditional transmission line techniques

Increasing frequency:

- Severe limitations on **sample thicknesses**
- Incompatible** sample dimension requirements between techniques
- Higher **sensitivity to operator**

## Our project:

- |                              |                         |                              |
|------------------------------|-------------------------|------------------------------|
| • 3M                         | • Georgia Tech          | • Mosaic Microsystems        |
| • AGC-Nelco                  | • Showa Denko Materials | • NIST                       |
| • Ajinomoto USA              | • IBIDEN Co Ltd         | • Nokia                      |
| • AT&S                       | • IBM                   | • Panasonic                  |
| • Centro Ricerche FIAT-FCA   | • Intel                 | • QWED                       |
| • Dell                       | • Isola                 | • Shengyi Technology Company |
| • Dupont                     | • ITRI (Co-Chair)       | • Sheldahl                   |
| • EMD Electronics (Co-Chair) | • Keysight (Co-Chair)   | • Unimicron Technology Corp  |
| • Flex                       | • MacDermid-Alpha       | • Zestron                    |



# iNEMI 5G Round Robin Overview

## Sample Material Requirements

- Stable, Low loss
- Low moisture absorption / temperature dependency
- Isotropic
- Good mechanical & handling properties

## Current Selection

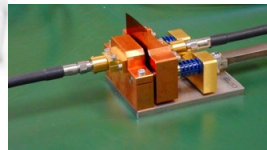
- Precision Teflon
- Cyclo Olefin Polymer

## Future additions

- Rexolite
- Fused Silica

## Techniques Included

- Split Post Dielectric Resonator
- Split Cavity Resonator
- Fabry-Perot
- Balanced Circular Disk Resonator



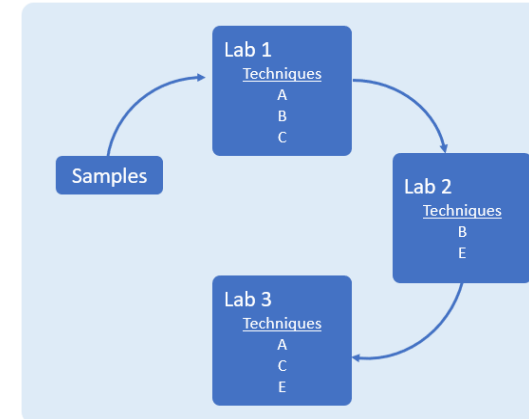
→ Frequency Span : 10GHz – 100GHz with overlaps

## 10 Sample Kits Created

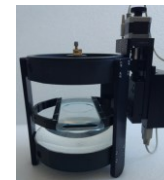
- Sample sizes 35 mm x 45 mm, 90 mm x 90 mm
- circulated between 10 labs

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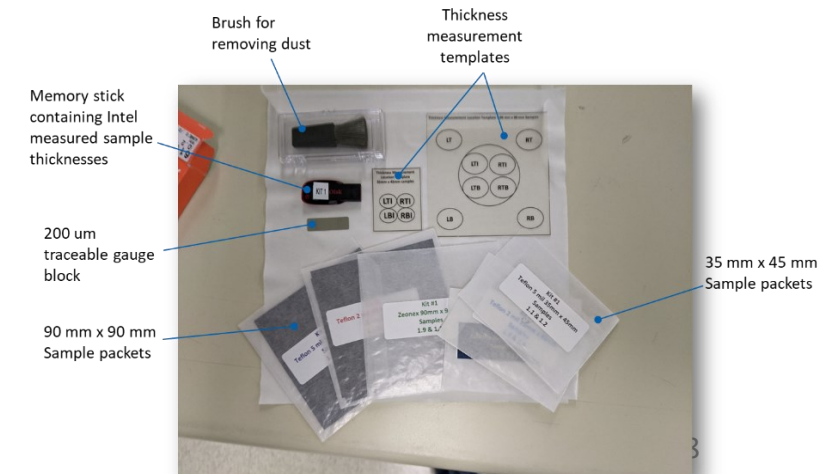
EuMC27 Measurements for 5G and 6G Systems



## 10 Laboratory Round Robin



**Our EUMC27-3 paper reports on:**  
**3 resonator techniques**  
**2 sample kits**  
**3 labs, each using 2+ techniques**  
**This presentation further includes**  
**4<sup>th</sup> lab & 4<sup>th</sup> technique**



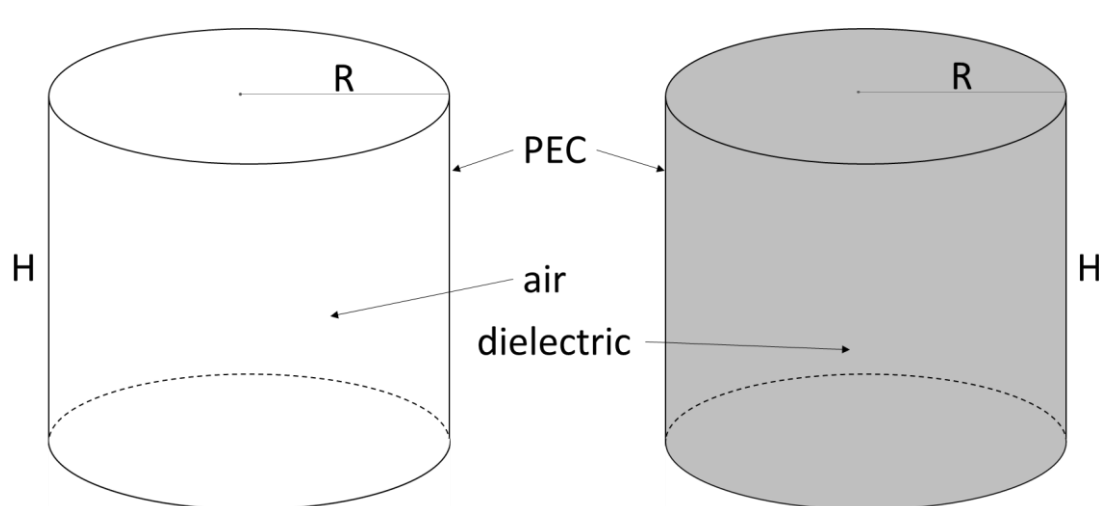


# Why Resonator methods

**Resonance in theory:** non-zero electromagnetic fields exist in isolated structures (no excitation).

Field properties are well-defined and **linked to material properties**.

E.g. for **cylindrical** cavities:

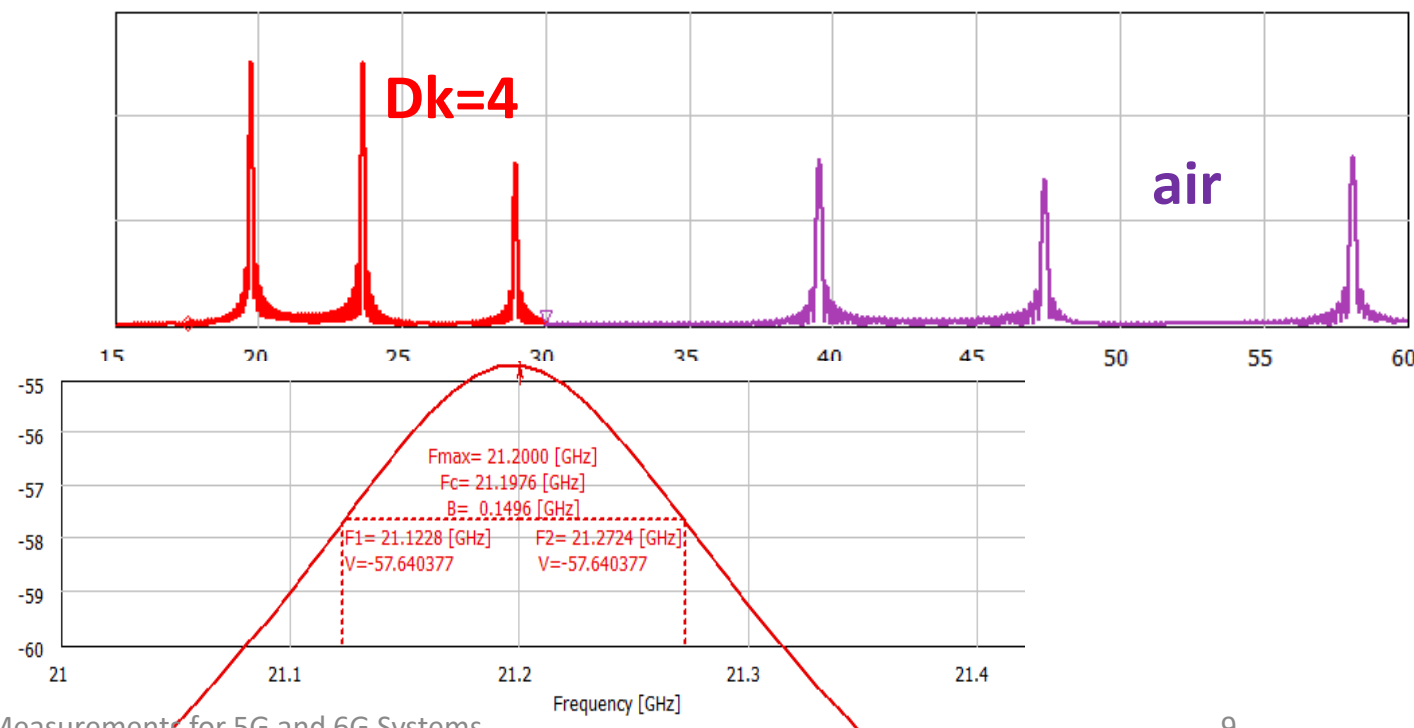


$$Q = 2\pi \frac{\iiint_V \epsilon \vec{E} \cdot \vec{E}^* dv}{T \iiint_V \sigma \vec{E} \cdot \vec{E}^* dv} = \frac{\omega \epsilon}{\sigma} = \frac{1}{Df} \approx \frac{f_{res}}{\Delta f}$$

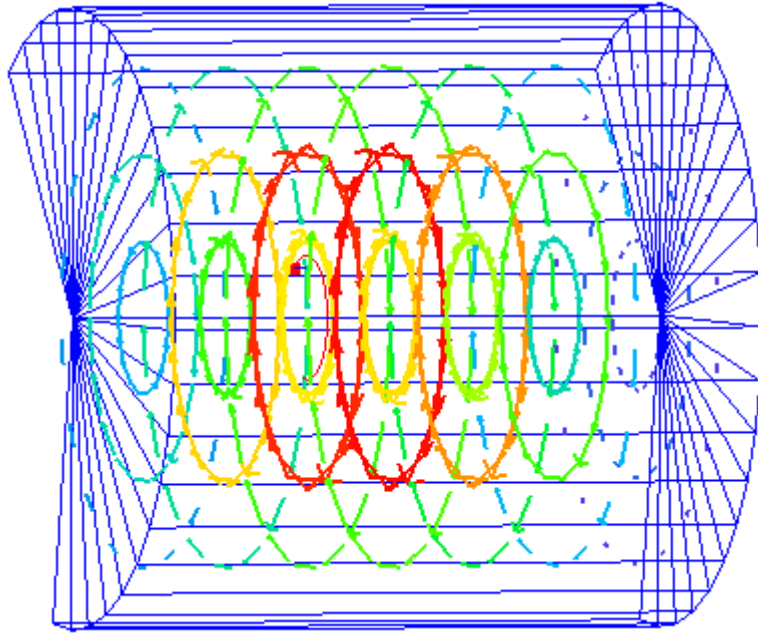
**Good sensitivity to low losses**

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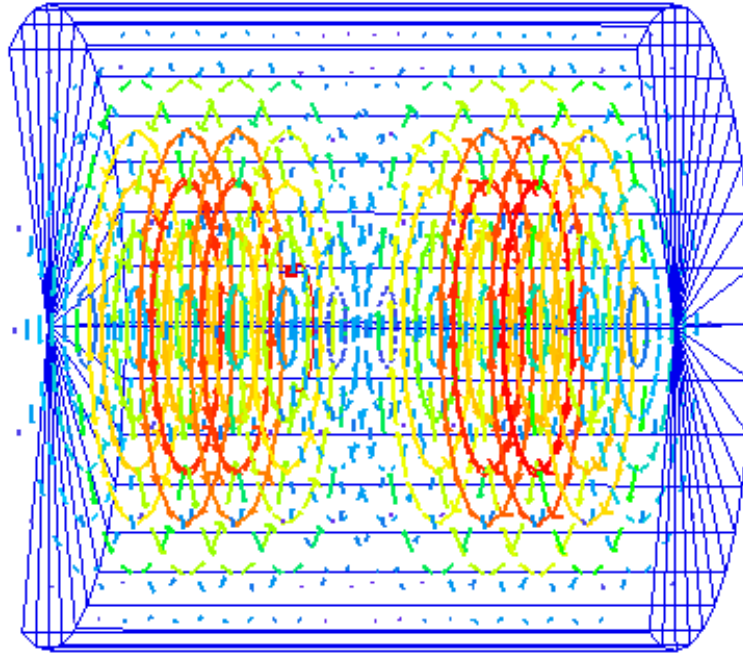
$$f_{r,mnp} = \frac{c}{\sqrt{Dk}} \sqrt{\left( \frac{\kappa_{mn}^{(i)}}{\pi R} \right)^2 + \left( \frac{p}{H} \right)^2} \quad \text{in non-magnetic low-loss dielectrics}$$



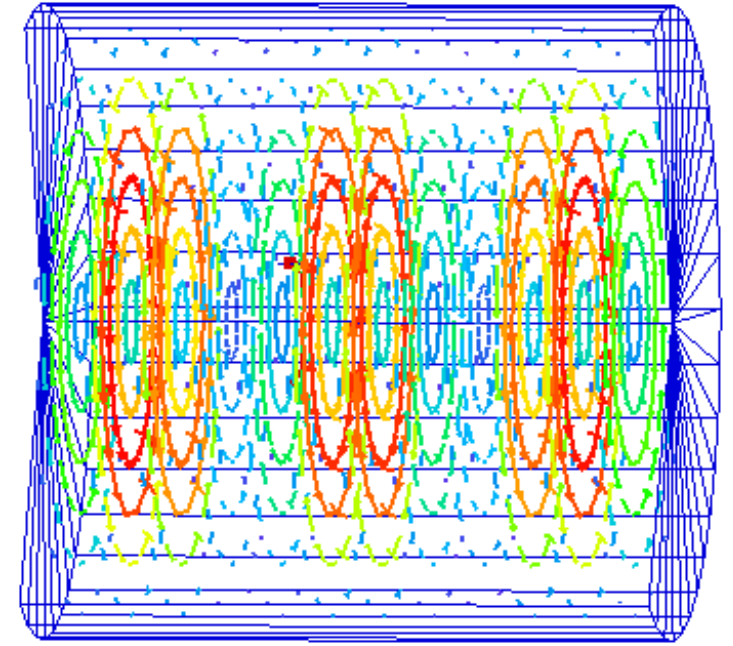
# Single- versus Multi-Mode Characterisation



**TE011 @ 29.43 GHz**



**TE012 @ 47.25 GHz**



**TE013 @ 57.95 GHz**

Resonators are **multimode** devices.

Hence formally, material measurement can be performed at **many frequencies** in the same resonator.

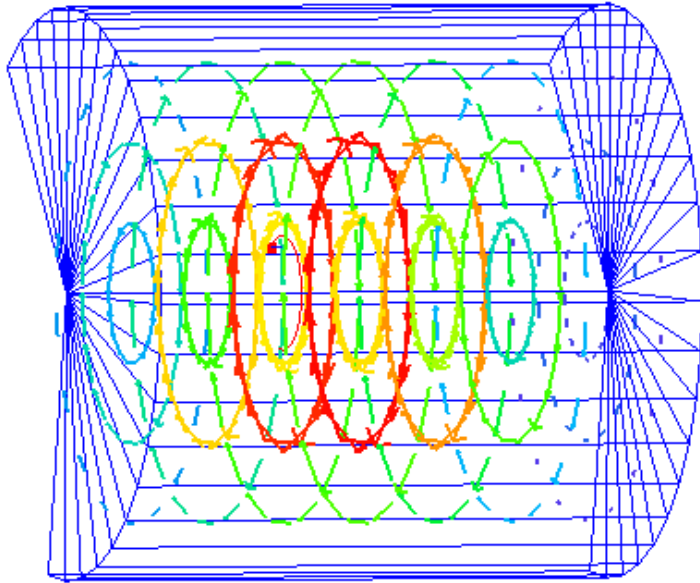
However, **some modes provide highest accuracy** of material characterization. Some are difficult to excite.

Software provided with the resonator is compatible only with modes pre-selected by the vendor.

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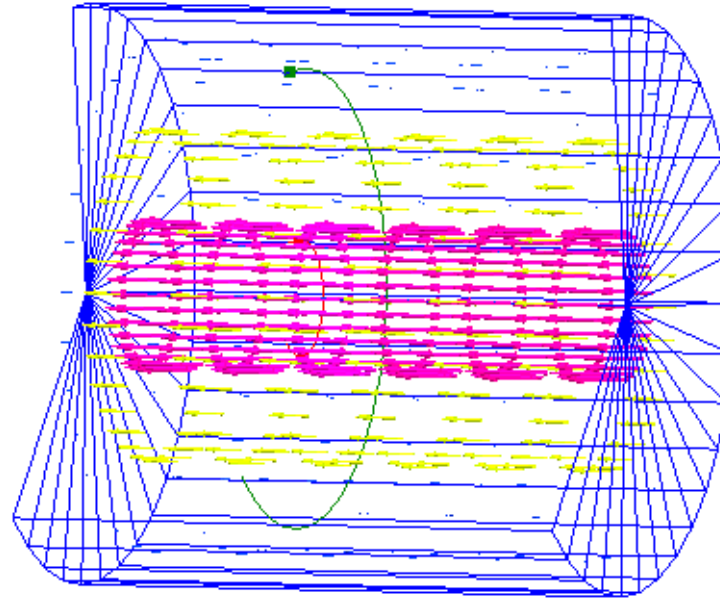
# In-Plane & Out-of-Plane Permittivity Measurements

## TE010



TE modes to measure  
in-plane component of  $D_k$ ,  $D_f$   
SCR, SPDR, FPOR

## TM010

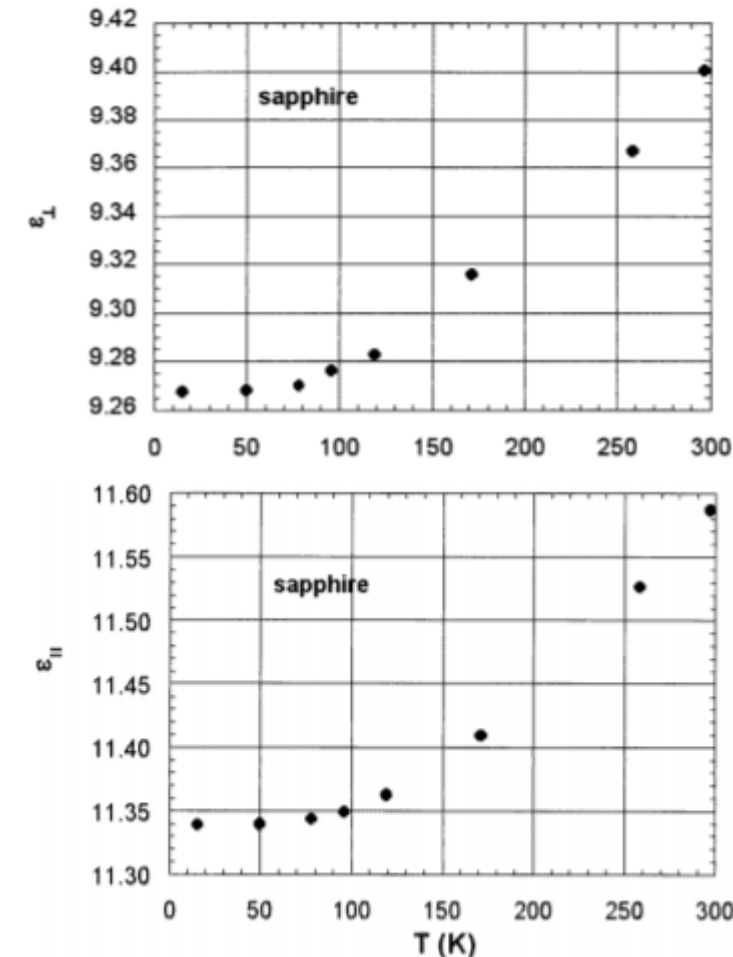


TM modes to measure  
out-of-plane component of  $D_k$ ,  $D_f$   
BCDR

Full characterisation of anisotropic materials (like crystals) requires both measurements.

BCDR not included in this presentation.

For the benchmarking round-robin, we selected isotropic materials.



J.Krupka et al., "Complex permittivity of some ultralow loss dielectric crystals..", Meas. Sci. Technol. 10 (1999).

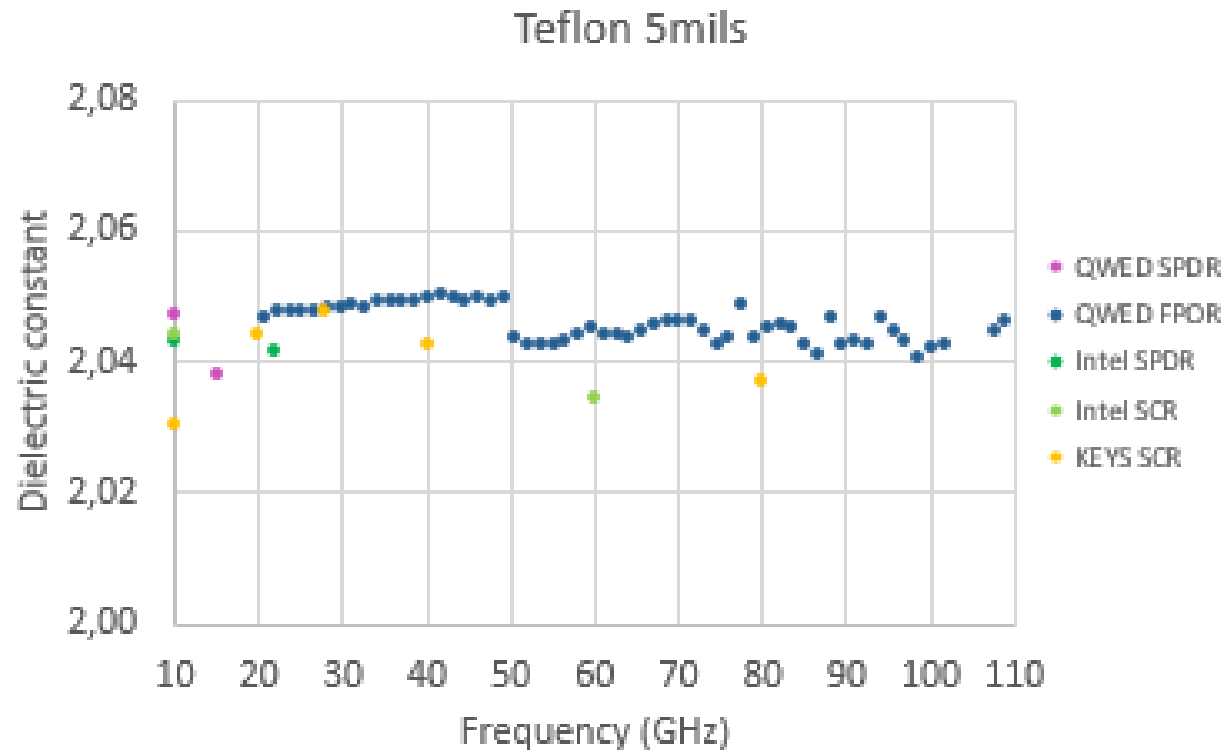
# Characterisation Results - Consistency

**3 labs, 3 techniques, 14 laboratory setups**

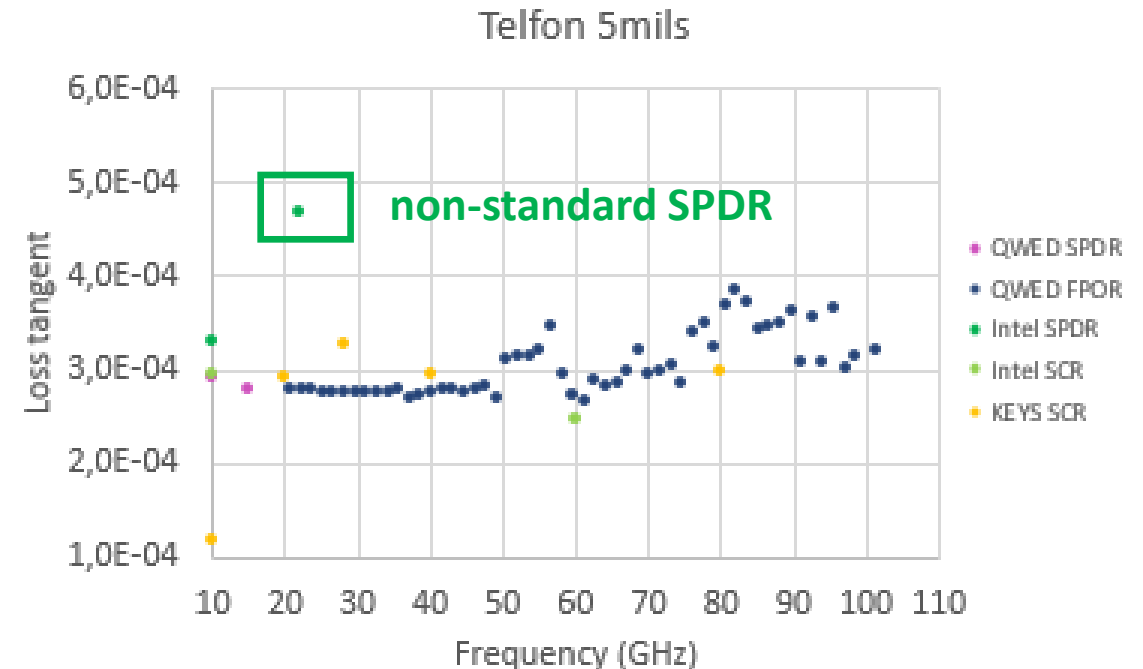
Intel - SCR at 10 / 60 GHz and SPDR at 10/ 20 GHz,

Keysight - SCR at 10 / 20 / 28 / 40 / 80 GHz

QWED - SPDR at 10/ 15 GHz and FPOR over 10-110GHz.



**Dk spread < 1% (within  $\pm 0.5\%$  from average)**





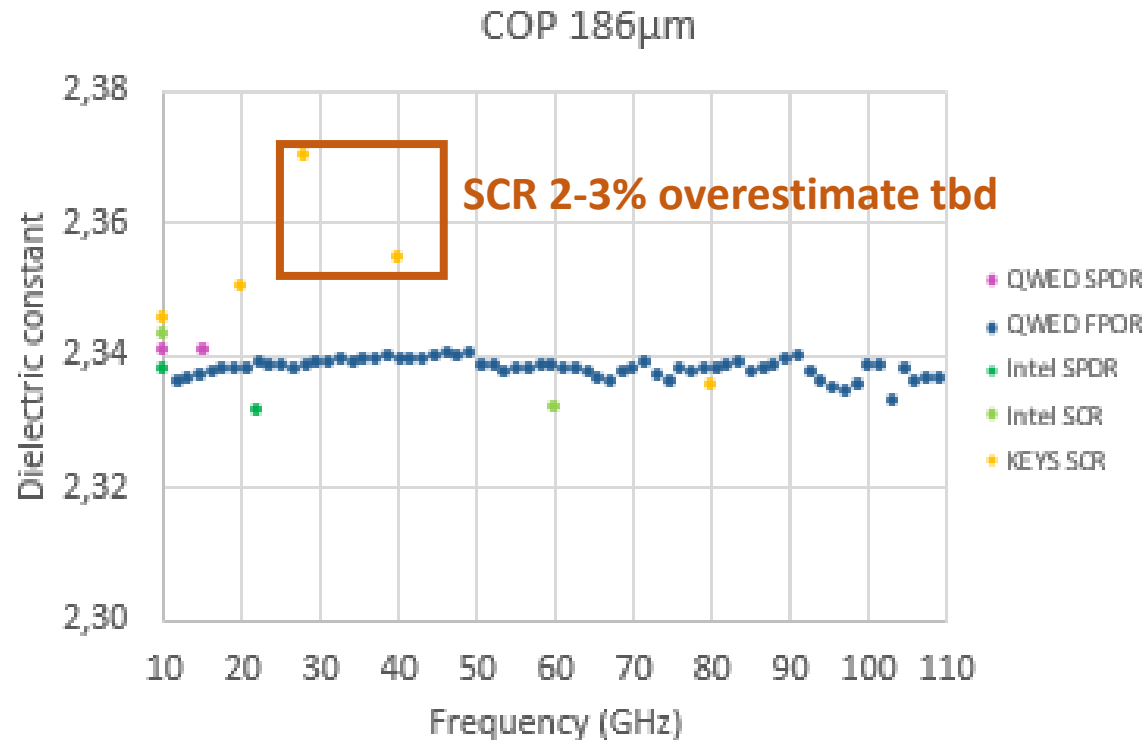
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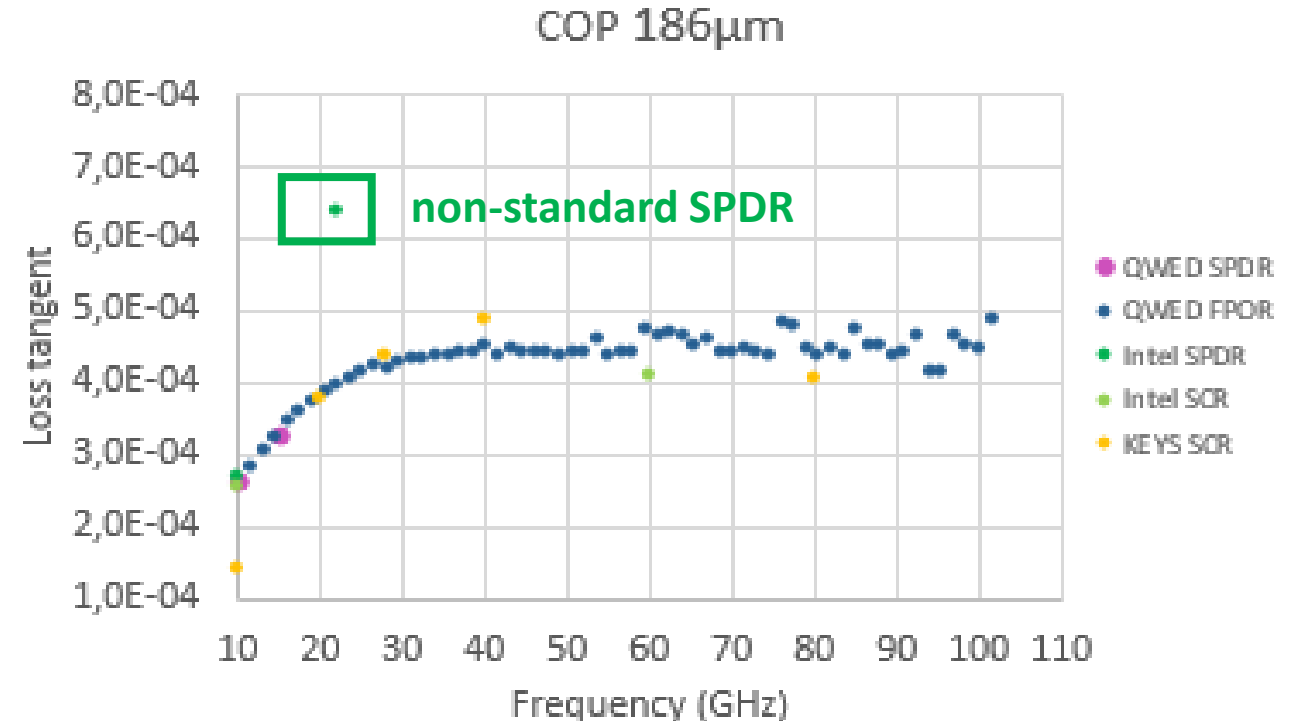
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**Dk spread < 1% (< 3% incl. outliers)**

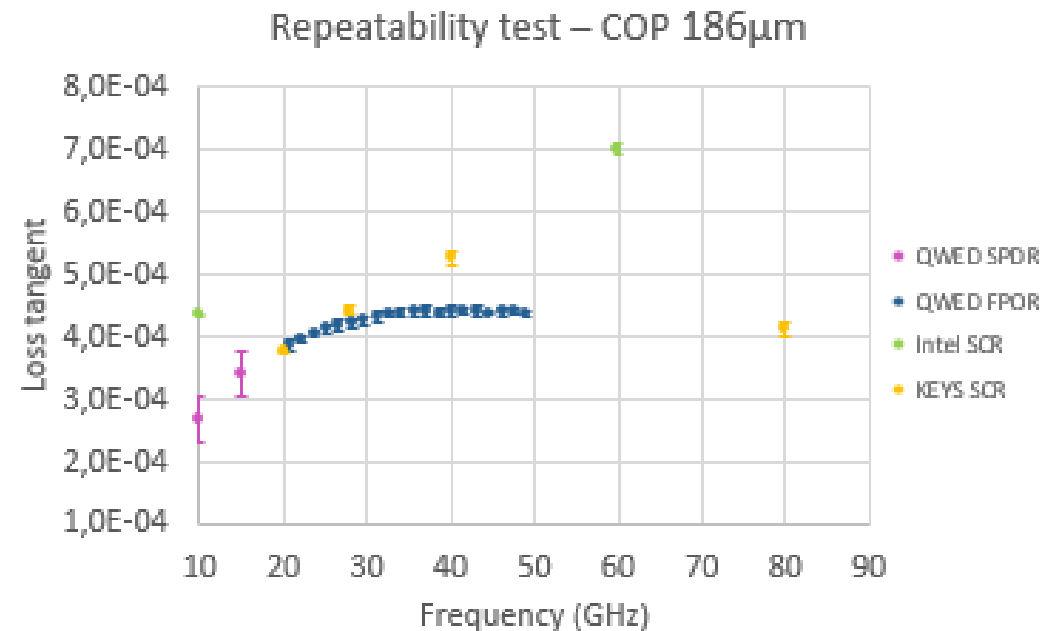
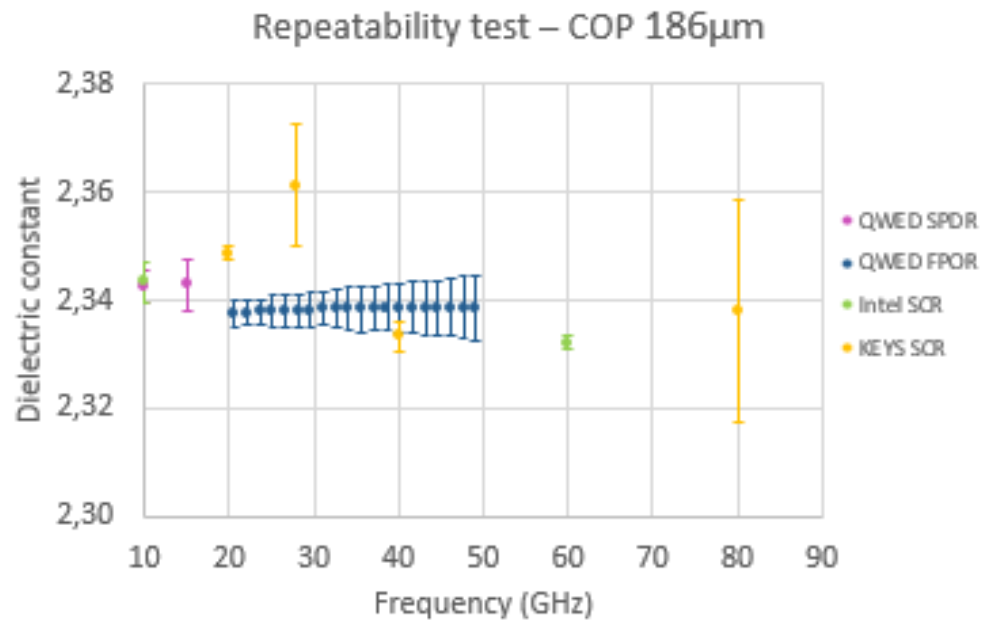


**> 40GHz 2x increase in Df compared to 10GHz**

# Characterisation Results - Repeatability

**3 labs, 3 techniques, 14 laboratory setups**  
**1 operator per setup**

Intel - SCR at 10 / 60 GHz and SPDR at 10/ 20 GHz,  
Keysight - SCR at 10 / 20 / 28 / 40 / 80 GHz  
QWED - SPDR at 10/ 15 GHz and FPOR over 10-110GHz.



**repeatability of SCR  $\pm 1\%$  (one operator spread 2%)**  
**repeatability of SPDR, FPOR better than  $\pm 0.5\%$**

each symbol denotes an average of 16 measurements; error bar - triple of standard deviation

# Concluding remarks

In the on-going iNEMI project, the four resonator techniques (SCR, SPDR, BCDR, FPOR) are studied in terms of **accuracy**, **repeatability**, and **reproducibility** of the metrology.

Each resonator technique has specific features, which can make it **preferable for a particular application** (e.g., different sample Dk / Df, thickness, expected anisotropy; frequency & temperature range of use).

Due to the lack of standards & SRMs for 5G/mmWaves, it is crucial to **benchmark** the techniques against one another, to **provide practical guidance to the industry**:

- samples compatible with more than one metrology are needed,
- **35mm x 45mm & 90mm x 90mm** together cover all the metrologies with overlaps.

**This paper** summarises **112** representative results out of over **1500** measurements performed by **10** labs with **3** techniques on **40** samples (here: from 186  $\mu\text{m}$  – thick Cyclo Olefin Polymer coupon and 5mils –thick Precision Teflon) :

- for each technique & lab, typical **repeatability** ( = 3 x std / mean) **< 0.5%**, (1% incl. outliers),
- **Dk spread** (between the 3 metrologies) **< 1%** (3% incl. non-standard outliers),
- for COP at  $f > 40\text{GHz}$ , **2x increase in Df** demonstrated compared to 10GHz.

Beyond the scope of this paper, the **round-robin has continued** on other samples (Teflon, fused silica, automotive,...) :

- similar & **consistent results** (rule of thumb: 1% in Dk),
- **no obvious bias by lab or by technique**,
- differences dominated by **sample to sample variation** (most likely - thickness variation within a coupon).

# ACKNOWLEDGEMENTS



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[https://www.inemi.org/article\\_content.asp?adminkey=5cc4f4100ebf2ba1f3e6fd6294749139&article=161](https://www.inemi.org/article_content.asp?adminkey=5cc4f4100ebf2ba1f3e6fd6294749139&article=161)



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